

# Search Notes



Application/Control No.

10/708,015

Examiner

Jean W. Désir

Applicant(s)/Patent under Reexamination

SHAN ET AL.

Art Unit

2622

## SEARCHED

Class	Subclass	Date	Examiner
348678	673	9/11/06	
	686		
	687		
382274	260		
updated		3/28/07	
search			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EA ST	9/11/06	